Application/Control No. 10/759,638 Applicant(s)/Patent Under Reexamination PANGRAZIO ET AL. Examiner Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|---------------------|----------------|
| * | Α | US-2003/0110085 | 06-2003 | Murren et al. | 705/26 |
| * | В | US-2004/0003352 | 01-2004 | Bargeron et al. | 715/530 |
| * | С | US-6,611,349 | 08-2003 | Vogt et al. | 358/1.15 |
| * | D | US-2002/0069282 | 06-2002 | Reisman, Richard R. | 709/227 |
| * | E | US-6,044,372 | 03-2000 | Rothfus et al. | 707/10 |
| * | F | US-6,829,770 | 12-2004 | Hinson et al. | 719/318 |
| * | G | US-2004/0093323 | 05-2004 | Bluhm et al. | 707/003 |
| * | н | US-2002/0007374 | 01-2002 | MARKS et al. | 707/513 |
| * | T | US-2002/0004808 | 01-2002 | MARKS et al. | 707/530 |
| * | J | US-2005/0010635 | 01-2005 | Schwesig et al. | 709/203 |
| * | к | US-2004/0001498 | 01-2004 | Chen et al. | 370/401 |
| * | L | US-6,336,119 | 01-2002 | Banavar et al. | 707/104.1 |
| * | м | US-2003/0115291 | 06-2003 | Kendall et al. | 709/219 |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name · | Classification |
|---|---|--|-----------------|---------|--------|----------------|
| | N | | | | | |
| | 0 | | | | | |
| | Р | | | | | |
| | Q | | | | · | |
| | R | | | | | |
| | s | | | | · | |
| | Т | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) | | | | |
|---|---|---|--|--|--|--|
| | υ | | | | | |
| | > | | | | | |
| | w | | | | | |
| | x | | | | | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.